

Application/Control No.	Applicant(s)/Patent u	Applicant(s)/Patent under Reexamination	
10/691,568	LEE, WOO-HYOUN	LEE, WOO-HYOUNG	
Examiner	Art Unit		

2624

Greg F. Cunningham

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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USCAT, USPG-PUB, EPO, JOO, Derwent, USOCK, IBM-TOB	131/20	J.K.		